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Top View

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19N10VL-TN3-R-VB Datasheet

N-Channel 100 V (D-S) MOSFET

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N-Channel MOSFET

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PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A)	Q _g (Typ.)		
100	0.055 at V _{GS} = 10 V	25			
	0.057 at V _{GS} = 4.5 V	25	21nC		

FEATURES

- Trench power MOSFET
- 100 % UIS tested



APPLICATIONS

• Primary side switch

PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	V _{DS}	100	V		
Gate-Source Voltage		V _{GS}	± 20	V	
	T _C = 25 °C		25		
Continuous Durain Current (T. 175 °C)	T _C = 70 °C		20	-	
Continuous Drain Current (T _J = 175 °C)	T _A = 25 °C	I _D	12 ^{b, c}		
	T _A = 70 °C		10 ^{b, c}		
Pulsed Drain Current		I _{DM}	75	A	
Continuous Course Drain Diada Courset	T _C = 25 °C		50 ^e		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	6.9 ^{b, c}		
Avalanche Current Pulse	1 0.1 mll	I _{AS}	33		
Single Pulse Avalanche Energy	he Energy L = 0.1 mH		55	mJ	
	T _C = 25 °C		83		
Maximum Davier Diagination	T _C = 70 °C		58	w	
Maximum Power Dissipation	T _A = 25 °C	P _D	8.3 ^{b, c}		
	T _A = 70 °C		5.8 ^{b, c}		
Operating Junction and Storage Temperature R	T _J , T _{sta}	-55 to +175	°C		

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum Junction-to-Ambient b, d	t ≤ 10 s	R _{thJA}	15	18	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	1.5	1.8	C/W	

Notes

a. Based on $T_C = 25 \ ^{\circ}C$.

b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. Maximum under steady state conditions is 50 °C/W.

e. Calculated based on maximum junction temperature. Package limitation current is 50 A.

19N10VL-TN3-R-VB

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SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	V_{GS} = 0 V, I_D = 250 μ A	100	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$		-	165	-	mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-11	-		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	1.0		3.5	V	
Gate-Source Leakage	I _{GSS}	V_{DS} = 0 V, V_{GS} = ± 20 V	-	-	± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 100 V, V _{GS} = 0 V V _{DS} = 100 V, V _{GS} = 0 V, T _J = 55 °C	-	-	1 10	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 V$, $V_{GS} = 10 V$	25	-	-	A	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V_{GS} = 10 V, I _D =12A V _{GS} =4.5 V, I _D =8A	-	0.055 0.057		Ω	
Forward Transconductance ^a	g _{fs}	V _{DS} = 15 V, I _D = 12 A	-	25	-	S	
Dynamic ^b	•						
Input Capacitance	C _{iss}		-	1800	-	pF	
Output Capacitance	Coss	V_{DS} = 12 V, V_{GS} = 0 V, f = 1 MHz	-	180	-		
Reverse Transfer Capacitance	C _{rss}		-	60	-		
Total Gate Charge	Qg		-	21	32	nC	
Gate-Source Charge	Q _{gs}	$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 12 \text{ A}$	-	10	-		
Gate-Drain Charge	Q _{gd}		-	9	-		
Gate Resistance	R _g	f = 1 MHz	-	1.5	-	Ω	
Turn-On Delay Time	t _{d(on)}		-	10	15	- ns	
Rise Time	t _r	$V_{DD} = 50 \text{ V}, \text{ R}_{L} = 5 \Omega$	-	10	15		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ 10 A, V_{GEN} = 10 V, R_g = 1 Ω	-	15	25		
Fall Time	t _f		-	10	15		
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C	-	-	50	A	
Pulse Diode Forward Current ^a	I _{SM}		-	-	40		
Body Diode Voltage	V _{SD}	I _S = 10 A	-	0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}		-	50	75	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	L = 10.4 di/dt = 100.4/vo T = 05.00	-	100	150	nC	
Reverse Recovery Fall Time	t _a	I _F = 10 A, di/dt = 100 A/μs, T _J = 25 °C	-	38	-	-	
Reverse Recovery Rise Time	t _b		-	12	-	ns	

Note

a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%.$

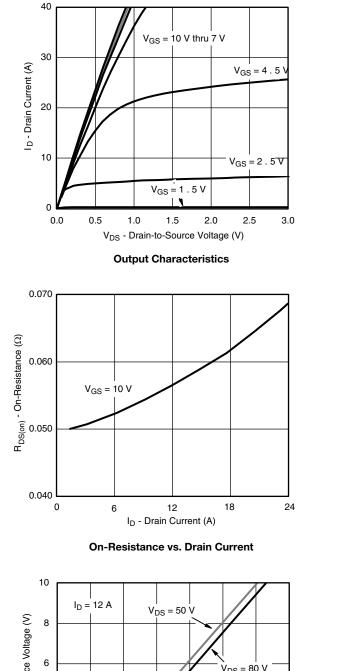
b. Guaranteed by design, not subject to production testing.

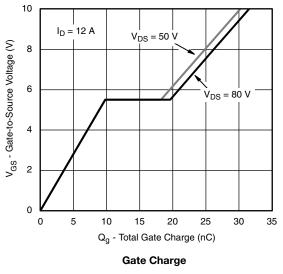
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

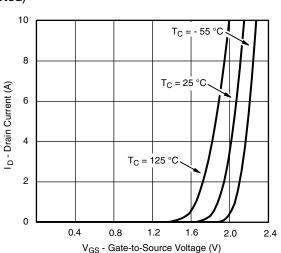
19N10VL-TN3-R-VB



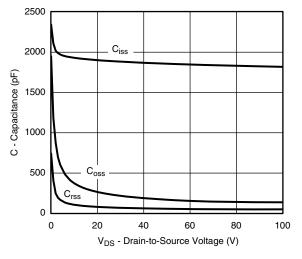
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



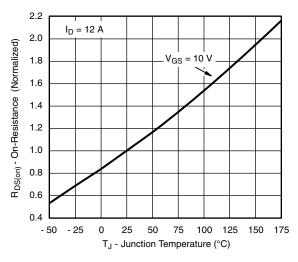




Transfer Characteristics

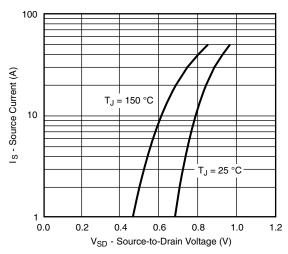




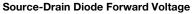


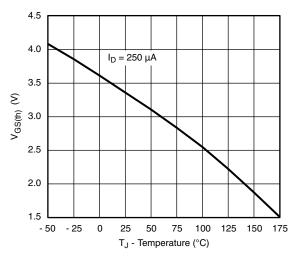
On-Resistance vs. Junction Temperature



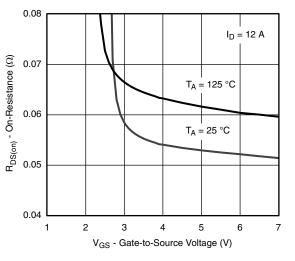


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

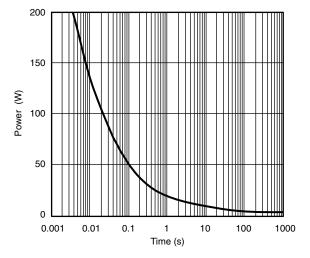




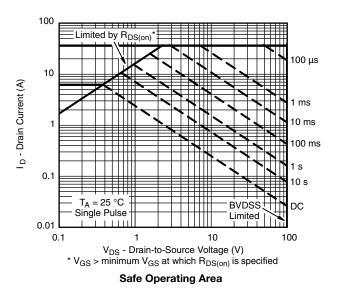




R_{DS(on)} vs. V_{GS} vs. Temperature

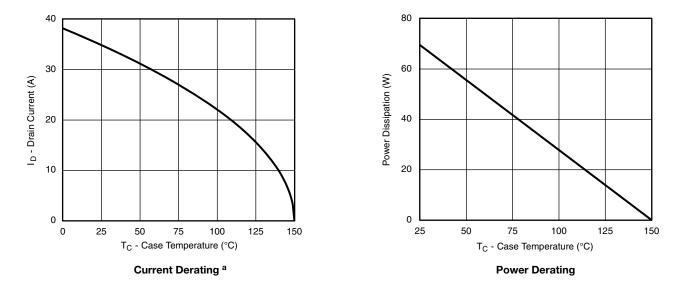


Single Pulse Power, Junction-to-Ambient





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

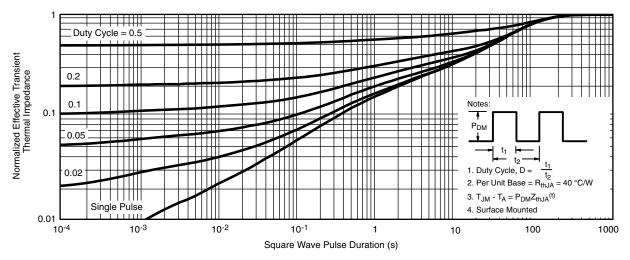


Note

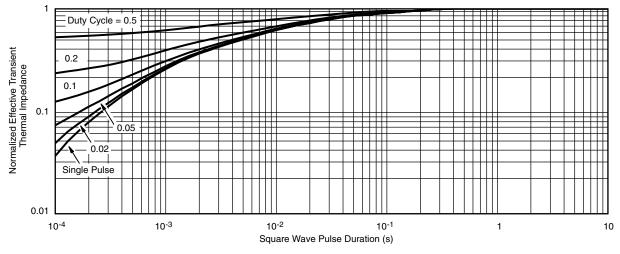
a. The power dissipation P_D is based on T_J (max.) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

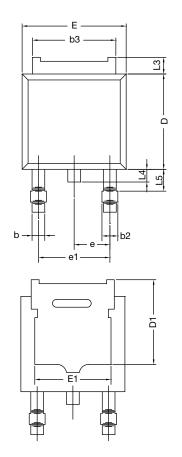


Normalized Thermal Transient Impedance, Junction-to-Ambient

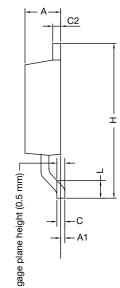


Normalized Thermal Transient Impedance, Junction-to-Case





TO-252AA Case Outline



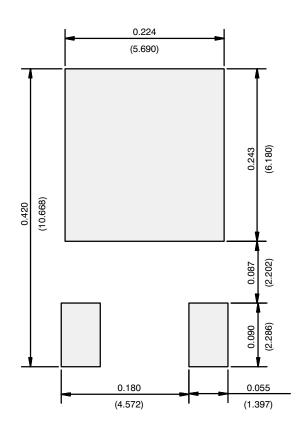
	MILLIN	IETERS	INCHES	
DIM.	MIN.	MAX.	MIN.	MAX.
А	2.18	2.38	0.086	0.094
A1	-	0.127	-	0.005
b	0.64	0.88	0.025	0.035
b2	0.76	1.14	0.030	0.045
b3	4.95	5.46	0.195	0.215
С	0.46	0.61	0.018	0.024
C2	0.46	0.89	0.018	0.035
D	5.97	6.22	0.235	0.245
D1	4.10	-	0.161	-
E	6.35	6.73	0.250	0.265
E1	4.32	-	0.170	-
Н	9.40	10.41	0.370	0.410
е	2.28 BSC		0.090 BSC	
e1	4.56 BSC		0.180 BSC	
L	1.40	1.78	0.055	0.070
L3	0.89	1.27	0.035	0.050
L4	-	1.02	-	0.040
L5	1.01	1.52	0.040	0.060
ECN: T16-0236-Rev. P, 16-May-16 DWG: 5347				

Notes

• Dimension L3 is for reference only.



RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads Dimensions in Inches/(mm)



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